

<b>Notice of References Cited</b>	Application/Control No. 10/568,442		Applicant(s)/Patent Under Reexamination PEREZ ET AL.	
	Examiner H. T. Le		Art Unit 1794	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,121,425	09-2000	Hainfeld et al.	530/391.5
*	B	US-6,369,206	04-2002	Leone et al.	530/391.5
*	C	US-7,125,822	10-2006	Nakano et al.	502/339
*	D	US-7,252,883	08-2007	Wakiya et al.	428/403
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

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	N					
	O					
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	R					
	S					
	I					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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